

ID	R _{DS} (ON)(Typ)	VDSS
20A	160mΩ	650V

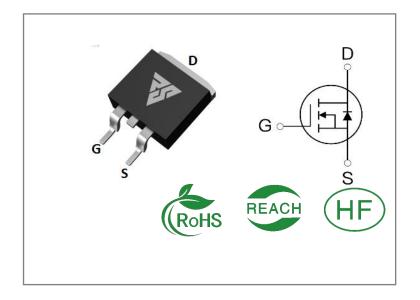
Applications:

- Switch Mode Power Supply(SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)
- AC-DC Switching Power Supply

Features:

- Fast switching speed
- 100% avalanche tested





Part Number	Package	Marking	Packing	Qty.
RS65R190S	T0-263	RS65R190S	Tape&reel	800 PCS

Absolute Maximun Ratings Tc= 25 ℃ unless otherwise specified

Symbol	Parameter	RS65R190S	Units	
VDSS	Drain-to-Source Voltage	650	V	
ID	Continuous Drain Current TC=25℃	20		
ID	Continuous Drain Current TC=100℃	13	A	
IDM Pulsed Drain Current (Note*1)		60		
PD	Power Dissipation	134	W	
VGS Gate- to- Source Voltage		±30	V	
EAS	Single Pulse Avalanche Engergy L=10mH,VDS= 50V, RG = 25 Ω , TC=25 $^{\circ}$ C	310	mJ	
dv/dt	MOSFET dv/ dt ruggedness VDS = 0400V	50	V/ns	
dv/dt	Reverse diode dv/dt VDS = 0400V, Tj = 25°C, ISD≤ID	15	V/ns	
	Maximum Temperature for Soldering	300		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	260	$^{\circ}$	
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150		

^{*} Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the" Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS65R190S	Units	Test Conditions
				Drain lead soldered to water cooled
RθJC	Junction-to-Case	0.93		heatsink, PD adjusted for a peak
			°C/ W	junction temperature of + 1 5 0 $^{\circ}$ C
RθJA	Junction-to- Ambient	60		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25 [°]C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
BVDSS	Drain- to- source Breakdown Voltage		650 V		V	VGS=0V,ID=250μA	
IDSS	Drain- to- Source Leakage Current			1	μΑ	VDS=650V,VGS=0 V	
	Gate- to- Source Forward Leakage			100		VGS=30V ,VDS=0V	
IGSS	Gate- to- Source Reverse Leakage			-100	nA	VGS=-30V ,VDS=0 V	

ON Characteristics TJ=25 °C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On- Resistance(Note*2)		160	190	mΩ	VGS=10V,ID=10A
VGS(TH)	Gate Threshold Voltage	2		4	V	VGS=VDS,ID=250μ A

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		23			
trise	Rise Time		35			VDS=325V
td(OFF)	Turn- OFF Delay Time		113		nS	ID=20A RG=25Ω
tfall	Fall Time		28			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		1490	1		VGS=0V
Coss	Output Capacitance		101	1	pF	VDS=50V
Crss	Reverse Transfer Capacitance		2.3			f=1.0MHz
Qg	Total Gate Charge		36			VDS=520V
Qgs	Gate- to- Source Charge		7.2		nC	ID=20A
Qgd	Gate-to-Drain(" Miller") Charge		16			VGS=10V

Source-Drain Diode Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
IS	Continuous Source Current			20	Α	Integral pn- diode
ISM	Maximum Pulsed Current			60	Α	in MOSFET
VSD	Diode Forward Voltage			1.4	٧	IS=20A,VGS=0V
trr	Reverse Recovery Time		347		nS	VR=100V
Qrr	Reverse Recovery Charge		5		μC	IS=20A,di/dt=100A /μs

Notes:

^{* 1.} Repetitive rating, pulse width limited by maximum junction temperature.

^{* 2.} Pulse Test: Pulse width ≤ 300µs, Duty Cycle ≤ 2%



Typical Feature Curve

Figure 1. Output Characteristics

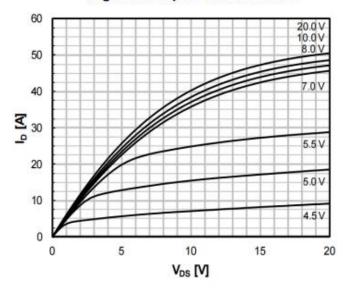


Figure 2. Transfer Characteristics

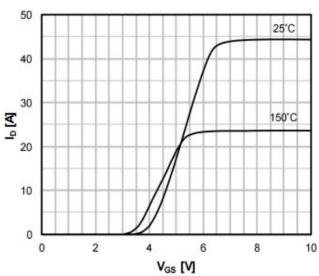


Figure 3. On-Resistance VS.Drain Current

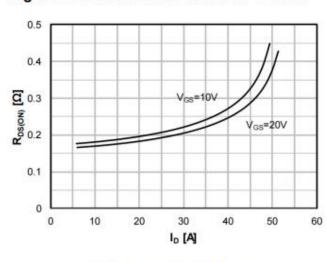


Figure 4. Capacitance

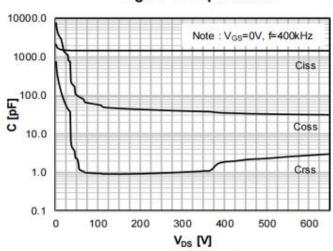
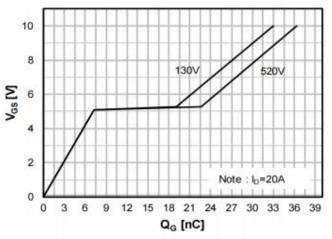
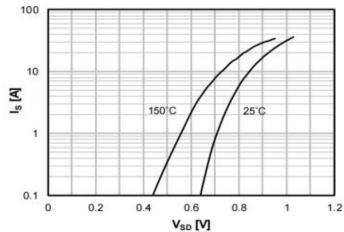


Figure 5. Gate Charge

Figure 6.Body Diode Forward Voltage





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Figure 7.On-Resistan ce vs. Junction Temperature

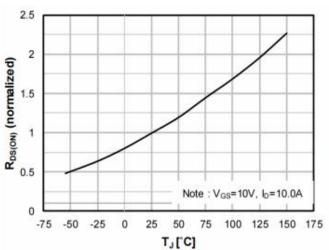


Figure 8.Bearkdown Voltage vs.

Junction Temperature

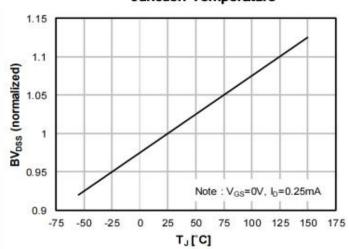


Figure 9.Safe operation area

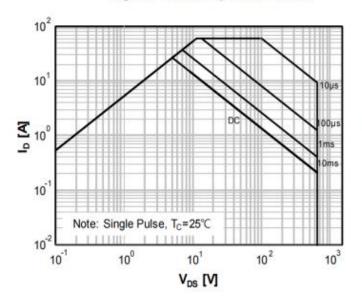
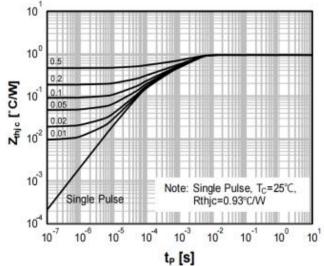


Figure 10.Transient Thermal Impedance





Test Circuits and Waveforms

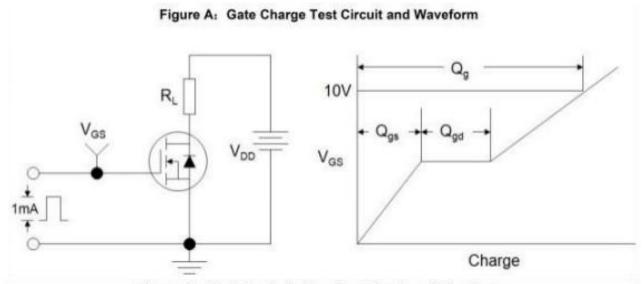


Figure B: Resistive Switching Test Circuit and Waveform

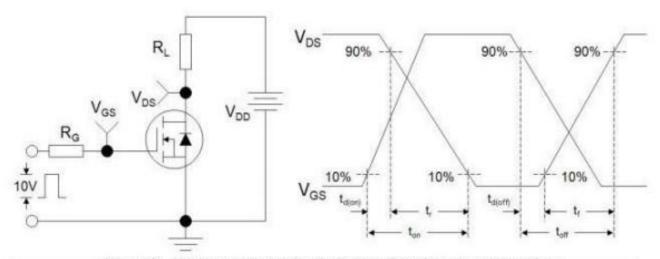
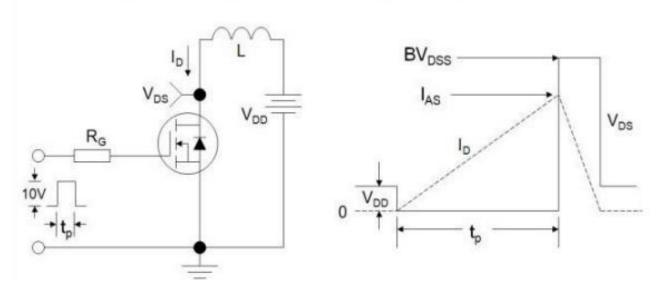
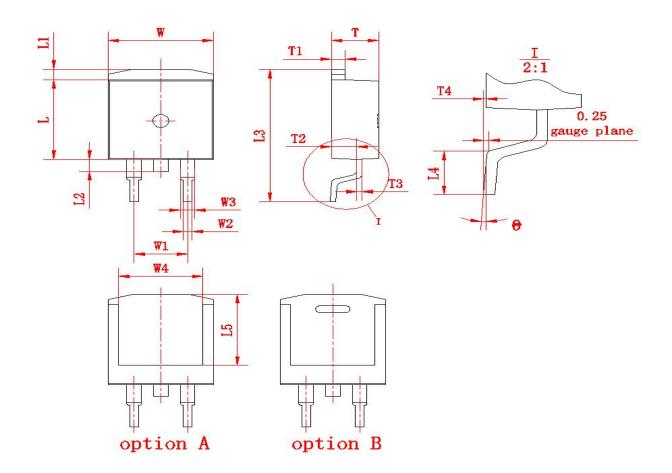


Figure C: Unclamped Inductive Switching Test Circuit and Waveform





Package outline drawing(TO-263 Unit: mm)



(单位: mm)

かロ	尺寸		尺寸 符号 符号		尺	[寸	nt o	尺寸	
符号	Min	Max	गिर	Min	Max	符号	Min	Max	
W	9. 80	10. 20	L1	1.00	1.40	T1	1. 20	1.40	
W1	(5.	08)	L2	1. 20	1.60	T2	2. 20	2. 60	
W2	0. 70	0. 95	L3	15. 00	15. 60	T3	0. 45	0. 65	
W3	1. 17	1. 62	L4	2. 20	2. 80	T4	0	0. 25	
W4	(8	. 0)	L5	(8. 2)		θ	0°	8°	
L	9. 00	9. 40	T	4. 30	4. 70				



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